

<b>Issue Classification</b>				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/024,048		FRENKEL, LIRON	
				Examiner		Art Unit	
				Sudhanshu C. Pathak		2611	

ORIGINAL				CROSS REFERENCE(S)									
CLASS		SUBCLASS		CLASS		SUBCLASS (ONE SUBCLASS PER BLOCK)							
375		219		375		222	232	260					
INTERNATIONAL CLASSIFICATION				370		401	210	310	329				
H	0	4	B	1/38		455	522						
				/		379	93.07						
				/									
				/									
				/									
Sudhanshu C. Pathak (Assistant Examiner) (Date)				Chieh M. Fan CHIEH M. FAN SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date) 7/20/07								Total Claims Allowed: 22	
(Legal Instruments Examiner) (Date)												O.G. Print Claim(s) 1	O.G. Print Fig. 5

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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5	5	35	65	95	125	155	185
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10	10	40	70	100	130	160	190
11	11	41	71	101	131	161	191
12	12	42	72	102	132	162	192
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15	15	45	75	105	135	165	195
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25		55	85	115	145	175	205
26		56	86	116	146	176	206
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